Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/695,375	BEZRUKOV ET AL.	
Examiner	Art Unit	
Chau Nguyen	2176	

SEARCHED				
Class	Subclass	Date	Examiner	
715	513	2/2/2006	CN	
715	530	2/2/2006	CN	
707	102	2/2/2006	CN	
707	103R	2/2/2006	CN	
707	103Y	2/2/2006	CN	
707	103Z	2/2/2006	CN	
707	200	2/2/2006	CN	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Reports	2/2/2006	CN	
	2/3/2006	CN	
NPL Search on IEEE Database	2/3/2006	CN .	